

**Search Notes**

Application/Control No.

10/662,831

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under  
Reexamination

HASKELL ET AL.

Art Unit

2178

**SEARCHED**

Class	Subclass	Date	Examiner
715	500.1	4/18/2007	CLH
	716	4/18/2007	CLH
	719	4/18/2007	CLH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
715	500.1	4/18/2007	CLH
	716	4/18/2007	CLH
Interference Search History Printout		4/18/2007	CLH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (USPAT, USPGPUB, JPO, EPO, Derwent)	4/18/2007	CLH
Google	4/18/2007	CLH
IEEE	4/18/2007	CLH